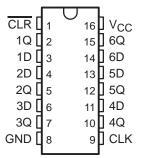
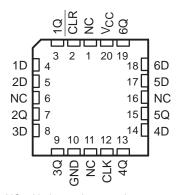
- 'ALS174 and 'AS174 Contain Six Flip-Flops With Single-Rail Outputs
- 'ALS175 and 'AS175B Contain Four Flip-Flops With Double-Rail Outputs
- **Buffered Clock and Direct-Clear Inputs**
- **Applications Include:**
 - Buffer/Storage Registers
 - Shift Registers
 - Pattern Generators

SN54ALS174, SN54AS174 . . . J PACKAGE SN74ALS174, SN74AS174 . . . D OR N PACKAGE (TOP VIEW)



SN54ALS174, SN54AS174 . . . FK PACKAGE (TOP VIEW)

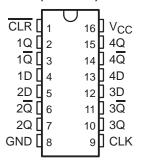


NC - No internal connection

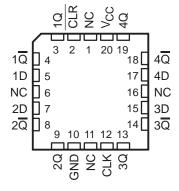
Fully Buffered Outputs for Maximum Isolation From External Disturbances ('AS Only)

Package Options Include Plastic Small-Outline (D) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

SN54ALS175, SN54AS175B . . . J PACKAGE SN74ALS175, SN74AS175B...D OR N PACKAGE (TOP VIEW)



SN54ALS175A, SN54AS175B . . . FK PACKAGE (TOP VIEW)



description

These positive-edge-triggered flip-flops utilize TTL circuitry to implement D-type flip-flop logic. All have a direct-clear (CLR) input. The 'ALS175 and 'AS175B feature complementary outputs from each flip-flop.

Information at the data (D) inputs meeting the setup-time requirements is transferred to the outputs on the positive-going edge of the clock pulse. Clock triggering occurs at a particular voltage level and is not directly related to the transition time of the positive-going pulse. When the clock (CLK) input is at either the high or low level, the D-input signal has no effect at the output.



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description (continued)

These circuits are fully compatible for use with most TTL circuits.

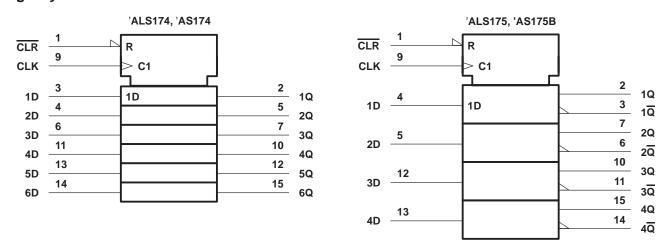
The SN54ALS174, SN54ALS175, SN54AS174, and SN54AS175B are characterized for operation over the full military temperature range of –55°C to 125°C. The SN74ALS174, SN74ALS175, SN74AS174, and SN74AS175B are characterized for operation from 0°C to 70°C.

FUNCTION TABLE (each flip-flop)

| | INPUTS | OUTI | PUTS | |
|-----|------------|------|----------------|------------------|
| CLR | CLK | D | Q | <u>Q</u> † |
| L | Χ | Χ | L | Н |
| Н | \uparrow | Н | Н | L |
| Н | \uparrow | L | L | Н |
| Н | L | Χ | Q ₀ | \overline{Q}_0 |

T'ALS175 and 'AS175B only

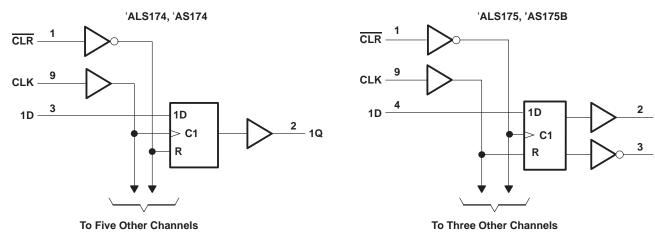
logic symbols‡



[‡] These symbols are in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the D, J, and N packages.



logic diagrams (positive logic)



Pin numbers shown are for the D, J, and N packages.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

| Supply voltage, V _{CC} | 7 V |
|---|----------------|
| Input voltage, V _I | 7 V |
| Operating free-air temperature range, T _A : SN54ALS174, SN54ALS175 | -55°C to 125°C |
| SN74ALS174, SN74ALS175 | 0°C to 70°C |
| Storage temperature range, T _{stq} | -65°C to 150°C |

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions

| | | | | SN54ALS174 SN54ALS175 | | SN74ALS174 SN74ALS175 | | | UNIT |
|-----------------|--------------------------------|--------------|------|--------------------------|------|--------------------------|-----|------|------|
| | | | MIN | NOM | MAX | MIN | NOM | MAX | |
| Vcc | Supply voltage | | 4.5 | 5 | 5.5 | 4.5 | 5 | 5.5 | V |
| VIH | High-level input voltage | | 2 | | | 2 | | | V |
| VIL | Low-level input voltage | | | | 0.8 | | | 0.8 | V |
| ІОН | High-level output current | | | | -0.4 | | | -0.4 | mA |
| l _{OL} | Low-level output current | | | | 4 | | | 8 | mA |
| fclock | Clock frequency | | 0 | | 40 | 0 | | 50 | MHz |
| | | CLR low | 15 | | | 10 | | | |
| t _W | Pulse duration | CLK high | 12.5 | | | 10 | | | ns |
| | | CLK low | 12.5 | | | 10 | | | |
| | Octor for before OLKA | Data | 15 | | | 10 | | | 20 |
| t _{su} | Setup time before CLK↑ | CLR inactive | 8 | | | 6 | | | ns |
| th | Hold time, data after CLK↑ | | 0 | | | 0 | | | ns |
| TA | Operating free-air temperature | | -55 | | 125 | 0 | | 70 | °C |

SN54ALS174, SN54ALS175, SN54AS174, SN54AS175B SN74ALS174, SN74ALS175, SN74AS174, SN74AS175B HEX/QUADRUPLE D-TYPE FLIP-FLOPS WITH CLEAR

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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

| PA | PARAMETER TEST CONDITIONS | | NDITIONS | | SN54ALS174 SN54ALS175 | | | SN74ALS174 SN74ALS175 | | | |
|-----------------|---------------------------|---|----------------------------|--------------------|--------------------------|-------|--------------------|--------------------------|------|------|--|
| | | | | | TYP [†] | MAX | MIN | TYP [†] | MAX | | |
| VIK | | $V_{CC} = 4.5 \text{ V},$ | $I_{I} = -18 \text{ mA}$ | | | -1.5 | | | -1.5 | V | |
| Vон | | $V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$ | $I_{OH} = -0.4 \text{ mA}$ | V _{CC} -2 | | | V _{CC} -2 | | | V | |
| V/01 | | V _{CC} = 4.5 V | I _{OL} = 4 mA | | 0.25 | 0.4 | | 0.25 | 0.4 | V | |
| VOL | | VCC = 4.5 V | $I_{OL} = 8 \text{ mA}$ | | | | | 0.35 | 0.5 | V | |
| Ц | | $V_{CC} = 5.5 \text{ V},$ | V _I = 7 V | | | 0.1 | | | 0.1 | mA | |
| lн | | $V_{CC} = 5.5 \text{ V},$ | V _I = 2.7 V | | | 20 | | | 20 | μΑ | |
| 1 | All others | \\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\ | V _I = 0.4 V | | | -0.1 | | | -0.1 | mA | |
| IIL. | CLK | V _{CC} = 5.5 V, | V = 0.4 V | | | -0.15 | | | | IIIA | |
| lo [‡] | | V _{CC} = 5.5 V, | V _O = 2.25 V | -20 | | -112 | -30 | | -112 | mA | |
| laa | 'ALS174 | \\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\ | See Note 1 | | 11 | 19 | | 11 | 19 | mΛ | |
| Icc | 'ALS175 | V _{CC} = 5.5 V, | See Note 1 | | 8 | 14 | | 9 | 14 | mA | |

[†] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

switching characteristics (see Figure 1)

| PARAMETER | FROM | то | C _I | _ = 50 pF _ = 500 £ | | ' , | UNIT |
|------------------|---------|-----------------|----------------|------------------------|------------------|------------|------|
| | (INPUT) | IT) (OUTPUT) | | LS174 LS175 | SN74AI SN74AI | _ | |
| | | | MIN | MAX | MIN | MAX | |
| f _{max} | | | 40 | | 50 | | MHz |
| t _{PLH} | CLR | Any Q ('ALS175) | 3 | 20 | 5 | 18 | ns |
| t _{PHL} | CLR | Any Q | | 30 | 8 | 23 | 115 |
| ^t PLH | CLK | Any Q | 3 | 20 | 3 | 15 | ns |
| ^t PHL | OLK | (or Q, 'ALS175) | 5 | 24 | 5 | 17 | 115 |

[§] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.



[‡] The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, I_{OS}. NOTE 1: I_{CC} is measured with D inputs and CLR grounded, and CLK at 4.5 V.

SN54ALS174, SN54ALS175, SN54AS174, SN54AS175B SN74ALS174, SN74ALS175, SN74AS174, SN74AS175B HEX/QUADRUPLE D-TYPE FLIP-FLOPS WITH CLEAR

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

| Supply voltage, V _{CC} | 7 V |
|--|----------------|
| Input voltage, V _I | 7 V |
| Operating free-air temperature range, T _A : SN54AS174, SN54AS175B | -55°C to 125°C |
| SN74AS174, SN74AS175B | 0°C to 70°C |
| Storage temperature range, T _{stg} | –65°C to 150°C |

recommended operating conditions

| | | | | | N54AS17 54AS17 | | SN74AS174 SN74AS175B | | | UNIT |
|-------------------|--------------------------------|--------------|---------|-----|-------------------|-----|-------------------------|-----|-----|------|
| | | | | MIN | NOM | MAX | MIN | NOM | MAX | |
| Vcc | Supply voltage | | | 4.5 | 5 | 5.5 | 4.5 | 5 | 5.5 | V |
| VIH | High-level input voltage | | | 2 | | | 2 | | | V |
| V _{IL} | Low-level input voltage | | | | | 0.8 | | | 0.8 | V |
| IOH | High-level output current | | | | | -2 | | | -2 | mA |
| loL | Low-level output current | | | | | 20 | | | 20 | mA |
| fclock* | Clock frequency | | | 0 | | 100 | 0 | | 100 | MHz |
| | | CLR low | | 5.5 | | | 5 | | | |
| . * | Pulse duration | CLK high | | 4 | | | 4 | | | ns |
| t _W * | ruise duration | CLK low | 'AS174 | 6 | | | 6 | | | 115 |
| | | CLK IOW | 'AS175B | 5 | | | 5 | | | |
| | | Data | 'AS174 | 4 | | | 4 | | | |
| t _{su} * | Setup time before CLK↑ | Data | 'AS175B | 3 | | | 3 | | | ns |
| | | CLR inactive | | 6 | | | 6 | | | |
| t _h * | Hold time, data after CLK↑ | | | 1 | | | 1 | | | ns |
| T _A | Operating free-air temperature | | | -55 | | 125 | 0 | | 70 | °C |

^{*} On products compliant to MIL-STD-883, Class B, this parameter is based on characterization data but is not production tested.

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

SN54ALS174, SN54ALS175, SN54AS174, SN54AS175B SN74ALS174, SN74ALS175, SN74AS174, SN74AS175B HEX/QUADRUPLE D-TYPE FLIP-FLOPS WITH CLEAR

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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER | | TEST CONDITIONS | | SN54AS174 SN54AS175B | | | SN SN7 | UNIT | | |
|------------------|---------|---|--------------------------|-------------------------|------------------|------|--------------------|------------------|------|------|
| | | | | MIN | TYP [†] | MAX | MIN | TYP [†] | MAX | |
| VIK | | V _{CC} = 4.5 V, | I _I = -18 mA | | | -1.2 | | | -1.2 | V |
| Vон | | $V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$ | $I_{OH} = -2 \text{ mA}$ | V _{CC} -2 | | | V _{CC} -2 | | | V |
| VOL | | $V_{CC} = 4.5 \text{ V},$ | $I_{OL} = 20 \text{ mA}$ | | 0.35 | 0.5 | | 0.35 | 0.5 | V |
| IĮ | | $V_{CC} = 5.5 \text{ V},$ | V _I = 7 V | | | 0.1 | | | 0.1 | mA |
| lіН | | $V_{CC} = 5.5 \text{ V},$ | V _I = 2.7 V | | | 20 | | | 20 | μΑ |
| Ι _Ι L | | V _{CC} = 5.5 V, | V _I = 0.4 V | | | -0.5 | | | -0.5 | mA |
| lO [‡] | | V _{CC} = 5.5 V, | V _O = 2.25 V | -30 | | -112 | -30 | | -112 | mA |
| laa | 'AS174 | V-0-55V | See Note 2 | | 30 | 45 | | 30 | 45 | mA |
| lcc lcc | 'AS175B | $V_{CC} = 5.5 \text{ V},$ | | | 22.5 | 34 | | 22.5 | 34 | IIIA |

[†] All typical values are at V_{CC} = 5 V, T_A = 25°C.

switching characteristics (see Figure 1)

| PARAMETER | FROM (INPUT) | $\begin{tabular}{lllllllllllllllllllllllllllllllllll$ | | $C_L = 50 \text{ pF},$ $R_L = 500 \Omega,$ | | | UNIT |
|--------------------|-----------------|---|-----|--|-----|------|------|
| | , , | | | SN54AS174 | | S174 | |
| | | | MIN | MAX | MIN | MAX | |
| f _{max} * | | | 100 | | 100 | | MHz |
| ^t PHL | CLR | Any Q | 5 | 15 | 5 | 14 | ns |
| ^t PLH | CLK | Any O | 3.5 | 9.5 | 3.5 | 8 | no |
| ^t PHL | CLK | Any Q | 4.5 | 11.5 | 4.5 | 10 | ns |

^{*} On products compliant to MIL-STD-883, Class B, these parameters are based on characterization data but are not production tested.

switching characteristics (see Figure 1)

| PARAMETER | PARAMETER FROM TO (INPUT) (OUTPUT) | | C _L R _I | _ = 50 pF _ = 500 £ | | , | UNIT |
|--------------------|------------------------------------|----------------------------------|----------------------------------|------------------------|------------|-----|-----------------------|
| | | | SN54AS175B | | SN74AS175B | | SN54AS175B SN74AS175B |
| | | | MIN | MAX | MIN | MAX | |
| f _{max} * | | | 100 | | 100 | | MHz |
| t _{PLH} | | Any Q or Q | 4 | 10 | 4 | 9 | ns |
| t _{PHL} | CLR | Any Q or Q | 4.5 | 15 | 4.5 | 13 | 115 |
| ^t PLH | CLK | Any Q or $\overline{\mathbb{Q}}$ | 3 | 8.5 | 3 | 7.5 | ns |
| t _{PHL} | CLN | Ally Q of Q | 3 | 11 | 3 | 10 | 115 |

^{*} On products compliant to MIL-STD-883, Class B, this parameter is based on characterization data but is not production tested.

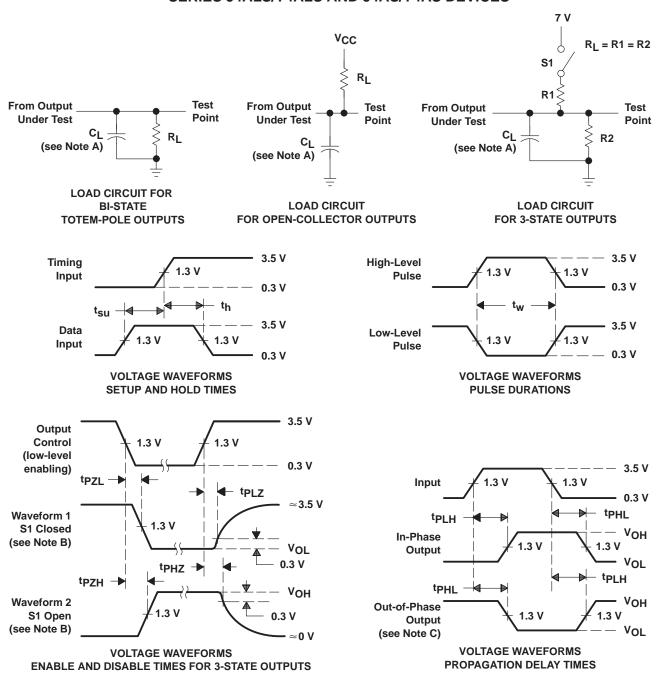


[‡] The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, I_{OS}. NOTE 2: I_{CC} is measured with D inputs, CLR, and CLK grounded.

[§] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

[§] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

PARAMETER MEASUREMENT INFORMATION SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
- D. All input pulses have the following characteristics: PRR \leq 1 MHz, $t_f = t_f = 2$ ns, duty cycle = 50%.
- E. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms



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